Power MOSFET 30 V, 7.5 A, Dual N-Channel, SOIC-8

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Dual SOIC-8 Surface Mount Package Saves Board Space
- This is a Pb–Free Device

Applications

- Disk Drives
- DC–DC Converters
- Printers

MAXIMUM RATINGS (T _J = 25° C unless otherwise state	d)
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Ratir	Symbol	Value	Unit		
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain	İ	T _A = 25°C	ID	5.5	Α
Current $R_{\theta JA}$ (Note 1)		T _A = 70°C		4.4	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	1.14	W
Continuous Drain		T _A = 25°C	۱ _D	4.5	Α
Current R _{0JA} (Note 2)	Steady	$T_A = 70^{\circ}C$		3.5	
Power Dissipation $R_{\theta JA}$ (Note 2)	State	T _A = 25°C	PD	0.68	W
Continuous Drain	1	T _A = 25°C	Ι _D	7.5	А
Current R _{θJA} t < 10 s (Note 1)		T _A = 70°C		6.0	
Power Dissipation $R_{\theta JA} t < 10 s (Note 1)$		T _A = 25°C	PD	1.95	W
Pulsed Drain Current	T _A = 25°C, t _p = 10 μs		I _{DM}	30	A
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to +150	°C
Source Current (Body Diode)			۱ _S	2.0	Α
Single Pulse Drain-to-Source Avalanche Energy T _J = 25°C, V _{DD} = 30 V, V _{GS} = 10 V, I _L = 7.5 A _{pk} , L = 1.0 mH, R _G = 25 Ω			EAS	28	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C	

THERMAL RESISTANCE RATINGS

Rating	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	R_{\thetaJA}	110	
Junction–to–Ambient – t≤10 s (Note 1)	R_{\thetaJA}	64	°C/W
Junction-to-FOOT (Drain)	$R_{\theta JF}$	40	0/11
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	183.5	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 inch sq pad size, 1 oz Cu.

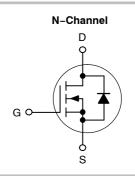
2. Surface-mounted on FR4 board using the minimum recommended pad size.



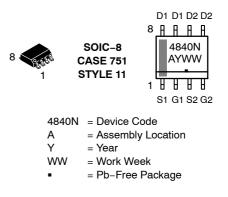
ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} Max	I _D Max
30 V	24 mΩ @ 10 V	7.5 A
00 1	36 mΩ @ 4.5 V	1.077



MARKING DIAGRAM & PIN ASSIGNMENT



ORDERING INFORMATION

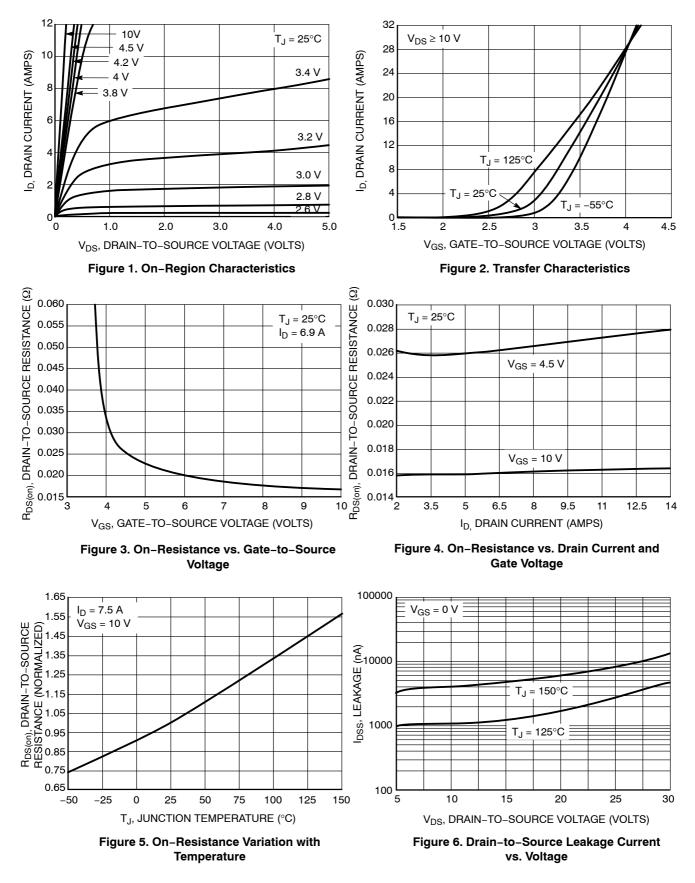
Device		Package	Shipping [†]
NTMD4840NR2	G	SOIC-8 (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

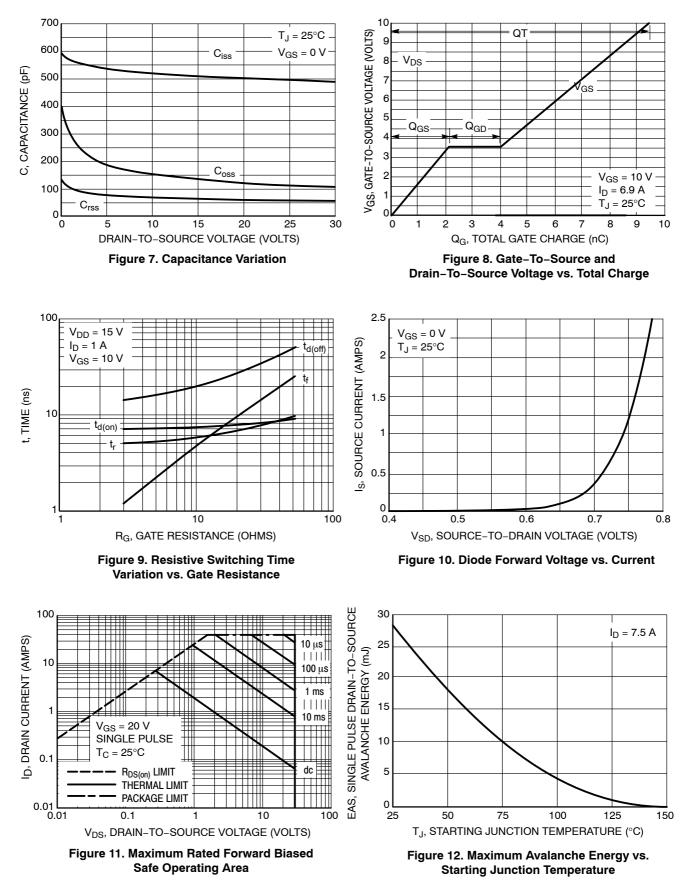
ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)jk

Characteristic	Symbol	Test Con	dition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 V, I_{D}$	o = 250 μA	30			V
Drain-to-Source Breakdown Voltage Tem- perature Coefficient	V _{(BR)DSS} /T _J				18		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C T _J = 100°C			1.0 10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V ₀	_{GS} = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)	4				<u> </u>		
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _I	_D = 250 μA	1.5		3.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 6.9 A		16	24	
		V _{GS} = 4.5 V	I _D = 5.0 A		26	36	mΩ
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V,	I _D = 6.9 A		15		S
CHARGES, CAPACITANCES AND GATE I	RESISTANCE						
Input Capacitance	C _{ISS}				520		ſ
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1.0 M	/IHz, V _{DS} = 15 V		140		pF
Reverse Transfer Capacitance	C _{RSS}		70		70		1
Total Gate Charge	Q _{G(TOT)}				4.8		
Threshold Gate Charge	Q _{G(TH)}		15 \/ 1 60 A		1.1		nC
Gate-to-Source Charge	Q _{GS}	V _{GS} = 4.5 V, V _{DS} =	15 V, I _D = 0.9 A		2.1		
Gate-to-Drain Charge	Q _{GD}				1.9		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 6.9 A			9.5		nC
SWITCHING CHARACTERISTICS (Note 4)	1						
Turn-On Delay Time	t _{d(ON)}				7.6		ſ
Rise Time	t _r	V _{GS} = 10 V, V	′ _{DD} = 15 V,		5.0		
Turn-Off Delay Time	t _{d(OFF)}	$I_{\rm D}$ = 1.0 A, $R_{\rm G}$ = 3.0 Ω			17		ns
Fall Time	t _f				3.0		1
DRAIN-TO-SOURCE CHARACTERISTICS	6						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V	$T_J = 25^{\circ}C$		0.76	1.0	V
		$I_{\rm D} = 2.0 {\rm A}$	T _J = 125°C		0.58		
Reverse Recovery Time	t _{RR}		-		12.5		
Charge Time	Ta	$V_{GS} = 0 V, d_{IS}/d$	_t = 100 A/μs,		7.3		ns
Discharge Time	Tb	$I_{\rm S} = 2.0 \rm{A}$			5.2		1
Reverse Recovery Time	Q _{RR}				6.0		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				0.66		nH
Drain Inductance	LD	T _A = 25°C			0.20		nH
Gate Inductance	L _G				1.50		nH
Gate Resistance	R _G				2.0	3.0	Ω

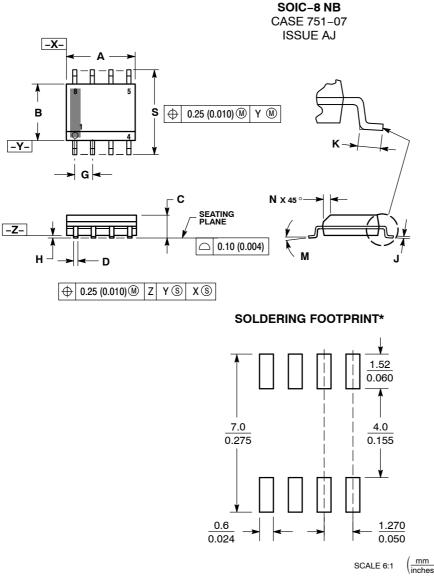
TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES



PACKAGE DIMENSIONS



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION A AND B DO NOT INCLUDE
- MOLD PROTRUSION. 4. MAXIMUM MOLD PROTRUSION 0.15 (0.006)
- PER SIDE. 5. DIMENSION D DOES NOT INCLUDE DAMBAR
- PROTRUSION ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

MAXIMUM MATERIAL CONDITION. 6. 751–01 THRU 751–06 ARE OBSOLETE. NEW STANDARD IS 751–07.

	MILLIN	IETERS	INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	4.80	5.00	0.189	0.197	
В	3.80	4.00	0.150	0.157	
С	1.35	1.75	0.053	0.069	
D	0.33	0.51	0.013	0.020	
G	1.27	7 BSC	0.05	0 BSC	
Н	0.10	0.25	0.004	0.010	
J	0.19	0.25	0.007	0.010	
κ	0.40	1.27	0.016	0.050	
М	0 °	8 °	0 °	8 °	
Ν	0.25	0.50	0.010	0.020	
S	5.80	6.20	0.228	0.244	

STYLE 11: PIN 1. SOURCE 1 2. GATE 1

<u>~</u> .	
3.	SOURCE 2

4. GATE 2 5. DRAIN 2

- 6. DRAIN 2
- 7. DRAIN 1 8. DRAIN 1

*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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